SCBS152E - MAY 1992 - REVISED JULY 1995

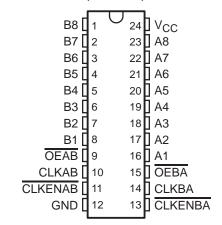
- State-of-the-Art Advanced BiCMOS Technology (ABT) Design for 3.3-V Operation and Low-Static Power Dissipation
- Support Mixed-Mode Signal Operation (5-V Input and Output Voltages With 3.3-V V<sub>CC</sub>)
- Support Unregulated Battery Operation Down to 2.7 V
- Typical V<sub>OLP</sub> (Output Ground Bounce)
   < 0.8 V at V<sub>CC</sub> = 3.3 V, T<sub>A</sub> = 25°C
- ESD Protection Exceeds 2000 V Per MIL-STD-883C, Method 3015; Exceeds 200 V Using Machine Model (C = 200 pF, R = 0)
- Latch-Up Performance Exceeds 500 mA Per JEDEC Standard JESD-17
- Bus-Hold Data Inputs Eliminate the Need for External Pullup Resistors
- Support Live Insertion
- Package Options Include Plastic Small-Outline (DW), Shrink Small-Outline (DB), and Thin Shrink Small-Outline (PW) Packages, Ceramic Chip Carriers (FK), and Ceramic (JT) DIPs

#### description

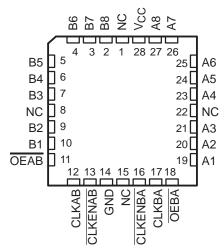
These octal bus transceivers and registers are designed specifically for low-voltage (3.3-V)  $V_{CC}$  operation, but with the capability to provide a TTL interface to a 5-V system environment.

The 'LVT2952 consist of two 8-bit back-to-back registers that store data flowing in both directions between two bidirectional buses. Data on the A or B bus is stored in the registers on the low-to-high

SN54LVT2952 . . . JT PACKAGE SN74LVT2952 . . . DB, DW, OR PW PACKAGE (TOP VIEW)



SN54LVT2952 . . . FK PACKAGE (TOP VIEW)



NC - No internal connection

transition of the clock (CLKAB or CLKBA) input provided that the clock-enable (CLKENAB or CLKENBA) input is low. Taking the output-enable (OEAB or OEBA) input low accesses the data on either port.

Active bus-hold circuitry is provided to hold unused or floating data inputs at a valid logic level.

To ensure the high-impedance state during power up or power down,  $\overline{OE}$  should be tied to  $V_{CC}$  through a pullup resistor; the minimum value of the resistor is determined by the current-sinking capability of the driver.

The SN74LVT2952 is available in TI's shrink small-outline package (DB), which provides the same I/O pin count and functionality of standard small-outline packages in less than half the printed-circuit-board area.

The SN54LVT2952 is characterized for operation over the full military temperature range of –55°C to 125°C. The SN74LVT2952 is characterized for operation from –40°C to 85°C.



Please be aware that an important notice concerning availability, standard warranty, and use in critical applications of Texas Instruments semiconductor products and disclaimers thereto appears at the end of this data sheet.



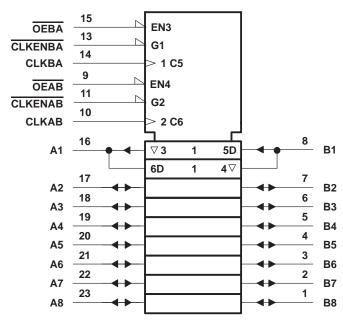
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#### **FUNCTION TABLE**<sup>†</sup>

	OUTPUT			
CLKENAB	CLKAB	OEAB	Α	В
Н	Х	L	Χ	В <sub>0</sub> ‡ В <sub>0</sub> ‡
Х	H or L	L	Χ	в <sub>0</sub> ‡
L	$\uparrow$	L	L	L
L	$\uparrow$	L	Н	Н
Х	X	Н	Χ	Z

<sup>†</sup>A-to-B data flow is shown; B-to-A data flow is similar but uses CLKENBA, CLKBA, and OEBA.

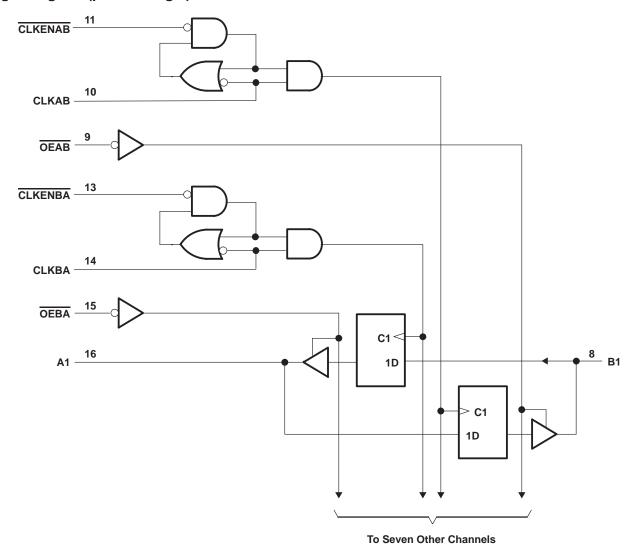
### logic symbol§



§ This symbol is in accordance with ANSI/IEEE Std 91-1984 and IEC Publication 617-12. Pin numbers shown are for the DB, DW, JT, and PW packages.

<sup>‡</sup>Level of B before the indicated steady-state input conditions were established

## logic diagram (positive logic)



Pin numbers shown are for the DB, DW, JT, and PW packages.

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## absolute maximum ratings over operating free-air temperature range (unless otherwise noted)†

Supply voltage range, V <sub>CC</sub>	. −0.5 V to 4.6 V
Input voltage range, V <sub>I</sub> (see Note 1)	0.5 V to 7 V
Voltage range applied to any output in the high state or power-off state, V <sub>O</sub> (see Note 1)	0.5 V to 7 V
Current into any output in the low state, IO: SN54LVT2952	96 mA
SN74LVT2952	128 mA
Current into any output in the high state, IO (see Note 2): SN54LVT2952	48 mA
SN74LVT2952	64 mA
Input clamp current, I <sub>IK</sub> (V <sub>I</sub> < 0)	–50 mA
Output clamp current, I <sub>OK</sub> (V <sub>O</sub> < 0)	–50 mA
Maximum power dissipation at T <sub>A</sub> = 55°C (in still air) (see Note 3): DB package	0.65 W
DW package	1.7 W
PW package	0.7 W
Storage temperature range, T <sub>stq</sub>	

<sup>†</sup> Stresses beyond those listed under "absolute maximum ratings" may cause permanent damage to the device. These are stress ratings only, and functional operation of the device at these or any other conditions beyond those indicated under "recommended operating conditions" is not implied. Exposure to absolute-maximum-rated conditions for extended periods may affect device reliability.

- NOTES: 1. The input and output negative-voltage ratings may be exceeded if the input and output clamp-current ratings are observed.
  - 2. This current flows only when the output is in the high state and  $V_O > V_{CC}$ .
  - 3. The maximum package power dissipation is calculated using a junction temperature of 150°C and a board trace length of 750 mils. For more information, refer to the *Package Thermal Considerations* application note in the 1994 *ABT Advanced BiCMOS Technology Data Book*. literature number SCBD002B.

#### recommended operating conditions (see Note 4)

					SN74LV		
			MIN	MAX	MIN	MAX	UNIT
VCC	Supply voltage		2.7	3.6	2.7	3.6	V
VIH	High-level input voltage		2	EN	2		V
VIL	Low-level input voltage			0.8		8.0	V
VI	Input voltage		, Q	5.5		5.5	V
loh	High-level output current		ζ)	-24		-32	mA
lOL	Low-level output current		200	48		64	mA
Δt/Δν	Input transition rise or fall rate	Outputs enabled	S.	10		10	ns/V
TA	Operating free-air temperature		-55	125	-40	85	°C

NOTE 4: Unused control inputs must be held high or low to prevent them from floating.

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# electrical characteristics over recommended operating free-air temperature range (unless otherwise noted)

	TEST CONDITIONS				54LVT29	52	SN74LVT2952			
PARAMETER	l Ti	EST CONDITIONS		MIN	TYP†	MAX	MIN	TYP <sup>†</sup>	MAX	UNIT
VIK	$V_{CC} = 2.7 \text{ V},$	I <sub>I</sub> = -18 mA				-1.2			-1.2	V
	$V_{CC} = MIN \text{ to } MAX^{\ddagger},$	$I_{OH} = -100  \mu A$		VCC-C	).2		VCC-0	).2		
Maria	$V_{CC} = 2.7 \text{ V},$	$I_{OH} = -8 \text{ mA}$		2.4			2.4			V
VOH	V 2.V	I <sub>OH</sub> = – 24 mA		2						V
	VCC = 3 V	$I_{OH} = -32 \text{ mA}$					2			
	V 27V	I <sub>OL</sub> = 100 μA				0.2			0.2	
	V <sub>CC</sub> = 2.7 V	I <sub>OL</sub> = 24 mA				0.5			0.5	
.,		I <sub>OL</sub> = 16 mA				0.4			0.4	.,
V <sub>OL</sub>	N 2 N	I <sub>OL</sub> = 32 mA				0.5	0.5		0.5	٧
	V <sub>CC</sub> = 3 V	I <sub>OL</sub> = 48 mA			0.55					
		I <sub>OL</sub> = 64 mA		4						
	$V_{CC} = 3.6 \text{ V},$	$V_I = V_{CC}$ or GND			F	±1			±1	
	$V_{CC} = 0$ or MAX $^{\ddagger}$ ,	V <sub>I</sub> = 5.5 V	Control inputs		Q	10			10	
l <sub>i</sub>		V <sub>I</sub> = 5.5 V			0,	20			20	μΑ
	V <sub>CC</sub> = 3.6 V	VI = VCC	A or B ports§		Q	5			5	
		V <sub>I</sub> = 0	]	Q		-10			-10	
l <sub>off</sub>	$V_{CC} = 0$ ,	$V_{I}$ or $V_{O} = 0$ to 4.5	V						±100	μΑ
	V 0 V	V <sub>I</sub> = 0.8 V		75			75			
I <sub>I</sub> (hold)	V <sub>CC</sub> = 3 V	V <sub>I</sub> = 2 V	A or B ports	-75			-75			μΑ
IOZH	V <sub>CC</sub> = 3.6 V,	V <sub>O</sub> = 3 V				1			1	μΑ
lozL	V <sub>CC</sub> = 3.6 V,	V <sub>O</sub> = 0.5 V				-1			-1	μΑ
			Outputs high		0.13	0.19		0.13	0.19	
I <sub>CC</sub>	$V_{CC} = 3.6 \text{ V},$ $V_{I} = V_{CC} \text{ or GND}$	$I_{O} = 0,$	Outputs low		8.8	12		8.8	12	mA
	A = ACC OL GIAD		Outputs disabled		0.13	0.19		0.13	0.19	
ΔI <sub>CC</sub> ¶	$V_{CC} = 3 \text{ V to } 3.6 \text{ V},$ Other inputs at $V_{CC}$ or	One input at V <sub>CC</sub> - GND	– 0.6 V,			0.2			0.2	mA
C <sub>i</sub>	V <sub>I</sub> = 3 V or 0				4.5			4.5		pF
C <sub>io</sub>	$V_O = 3 \text{ V or } 0$				11.5			11.5		pF

<sup>&</sup>lt;sup>†</sup> All typical values are at  $V_{CC} = 3.3 \text{ V}$ ,  $T_A = 25^{\circ}\text{C}$ .

<sup>‡</sup> For conditions shown as MIN or MAX, use the appropriate value specified under recommended operating conditions.

<sup>§</sup> Unused terminals at V<sub>CC</sub> or GND

This is the increase in supply current for each input that is at the specified TTL voltage level rather than V<sub>CC</sub> or GND.

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# timing requirement over recommended operating free-air temperature range (unless otherwise noted) (see Figure 1)

					SN54LVT2952				SN74LVT2952			
			V <sub>CC</sub> = 3.3 V ± 0.3 V		V <sub>CC</sub> = 2.7 V		V <sub>CC</sub> = 3.3 V ± 0.3 V		V <sub>CC</sub> = 2.7 V		UNIT	
			MIN	MAX	MIN	MAX	MIN	MAX	MIN	MAX		
fclock	Clock frequency							150		150	MHz	
t <sub>w</sub>	Pulse duration	CLK high			N		3.3		3.3		ns	
		CLK low			I.		3.3		3.3			
	Cotur time A on B before CLKA	Data high	2.6		2.9		2.5		2.8			
	Setup time, A or B before CLK↑	Data low	2.6	6	3.1		2.5		3			
t <sub>su</sub>	Out on the OF haten OUT	Data high	0.9	2	0.8		0.9		0.8		ns	
	Setup time, CE before CLK↑	Data low	2.5	20	2.7		2.4		2.7			
4.	Hold time, A or B after CLK↑ Hold time, CE after CLK↑		1.5	Q.	0.7		1.5		0.7			
th			2.6		2.6		2.5		2.6		ns	

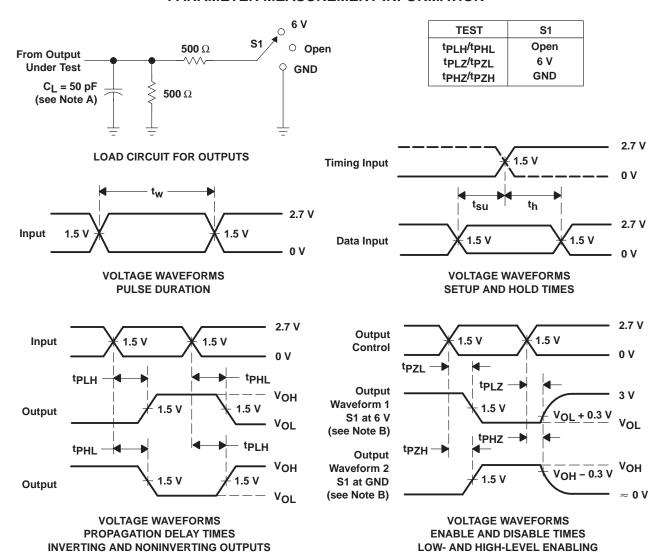
# switching characteristics over recommended operating free-air temperature range, $C_L$ = 50 pF (unless otherwise noted) (see Figure 1)

		SN54LVT2952				SN74LVT2952						
PARAMETER	FROM (INPUT)	TO (OUTPUT)	V <sub>CC</sub> = 3.3 V ± 0.3 V		V <sub>CC</sub> = 2.7 V		V <sub>CC</sub> = 3.3 V ± 0.3 V			VCC =	UNIT	
			MIN	MAX	MIN	MAX	MIN	TYP†	MAX	MIN	MAX	
f <sub>max</sub>					N.	,	150			150		MHz
tPLH .	CLKBA or CLKAB	A == D	1.3	6.4	2.7	7.4	1.3	3.6	6.1	2.7	7.1	
t <sub>PHL</sub>		A or B	1.8	6.1	2.7	7	1.8	3.7	6	2.7	6.9	ns
<sup>t</sup> PZH	OEBA or	A D	1	6.3	2.6	7.3	1	3.2	5.6	2.6	6.7	
t <sub>PZL</sub>	OEAB	A or B	1.1	6.6	2.9	8.2	1.2	3.2	6.5	2.9	8	ns
<sup>t</sup> PHZ	OEBA or	A or B	1	07	2.7	7.6	1	4.1	6.3	2.7	6.9	ns
t <sub>PLZ</sub>	OEAB	AUD	1.6	5.8	1.7	6	1.6	3.3	5.1	1.8	5.3	110

<sup>&</sup>lt;sup>†</sup> All typical values are at  $V_{CC}$  = 3.3 V,  $T_A$  = 25°C.

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#### PARAMETER MEASUREMENT INFORMATION



NOTES: A.  $C_L$  includes probe and jig capacitance.

- B. Waveform 1 is for an output with internal conditions such that the output is low except when disabled by the output control. Waveform 2 is for an output with internal conditions such that the output is high except when disabled by the output control.
- C. All input pulses are supplied by generators having the following characteristics: PRR  $\leq$  10 MHz,  $Z_Q = 50 \ \Omega$ ,  $t_f \leq 2.5 \ ns$ .
- D. The outputs are measured one at a time with one transition per measurement.

Figure 1. Load Circuit and Voltage Waveforms

DW (R-PDSO-G24)

## PLASTIC SMALL OUTLINE



NOTES: A. All linear dimensions are in inches (millimeters). Dimensioning and tolerancing per ASME Y14.5M-1994.

- B. This drawing is subject to change without notice.
- C. Body dimensions do not include mold flash or protrusion not to exceed 0.006 (0,15).
- D. Falls within JEDEC MS-013 variation AD.



PW (R-PDSO-G24)

#### PLASTIC SMALL OUTLINE



NOTES:

- A. All linear dimensions are in millimeters. Dimensioning and tolerancing per ASME Y14.5M—1994.
- B. This drawing is subject to change without notice.
- Body length does not include mold flash, protrusions, or gate burrs. Mold flash, protrusions, or gate burrs shall not exceed 0,15 each side.
- Body width does not include interlead flash. Interlead flash shall not exceed 0,25 each side.
- E. Falls within JEDEC MO-153



#### DB (R-PDSO-G\*\*)

#### PLASTIC SMALL-OUTLINE

#### **28 PINS SHOWN**



NOTES: A. All linear dimensions are in millimeters.

B. This drawing is subject to change without notice.

C. Body dimensions do not include mold flash or protrusion not to exceed 0,15.

D. Falls within JEDEC MO-150

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